

## N-Channel Depletion-Mode MOSFET Transistors

### Product Summary

Part Number	$V_{(BR)DSV}$ Min (V)	$r_{DS(on)}$ Max ( $\Omega$ )	$V_{GS(off)}$ (V)	$I_D$ (A)
ND2012L	200	12	-1.5 to -4	0.16
ND2020L		20	-0.5 to -2.5	0.132

### Features

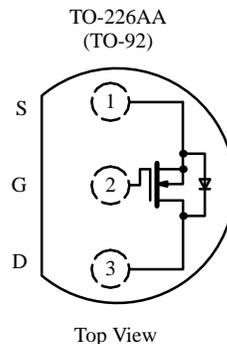
- High Breakdown Voltage: 220 V
- Normally "On" Low  $r_{DS}$  Switch: 9  $\Omega$
- Low Input and Output Leakage
- Low-Power Drive Requirement
- Low Input Capacitance

### Benefits

- Full-Voltage Operation
- Low Offset Voltage
- Low Error Voltage
- Easily Driven Without Buffer
- High-Speed Switching

### Applications

- Normally "On" Switching Circuits
- Current Sources/Limiters
- Power Supply, Converter Circuits
- Solid-State Relays
- Telecom Switches



### Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

Parameter	Symbol	ND2012L	ND2020L	Unit
Drain-Source Voltage	$V_{DS}$	200	200	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	$\pm 30$	
Continuous Drain Current ( $T_J = 150^\circ\text{C}$ )	$I_D$	$T_A = 25^\circ\text{C}$	0.16	A
		$T_A = 100^\circ\text{C}$	0.1	
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	0.8	0.8	
Power Dissipation	$P_D$	$T_A = 25^\circ\text{C}$	0.8	W
		$T_A = 100^\circ\text{C}$	0.32	
Maximum Junction-to-Ambient	$R_{thJA}$	156	156	$^\circ\text{C/W}$
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to 150		$^\circ\text{C}$

#### Notes

a. Pulse width limited by maximum junction temperature.

Updates to this data sheet may be obtained via facsimile by calling Siliconix FaxBack, 1-408-970-5600. Please request FaxBack document #70197. Applications information may also be obtained via FaxBack, request document #70612.

## Specifications<sup>a</sup>

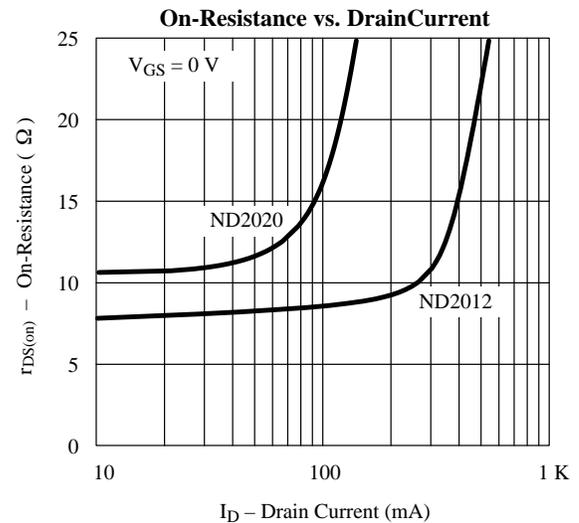
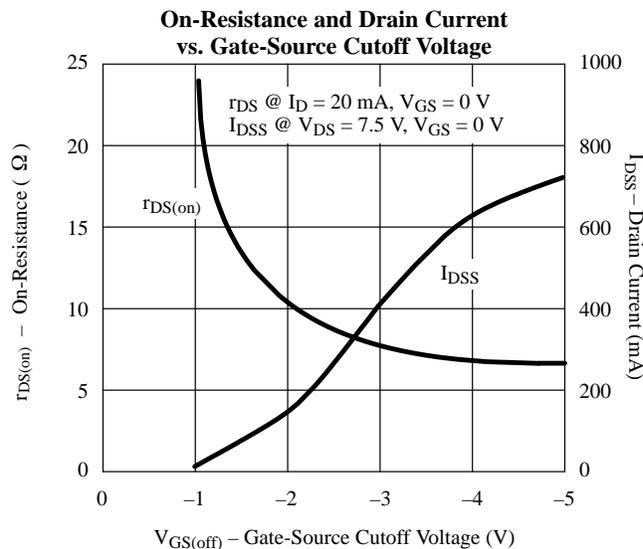
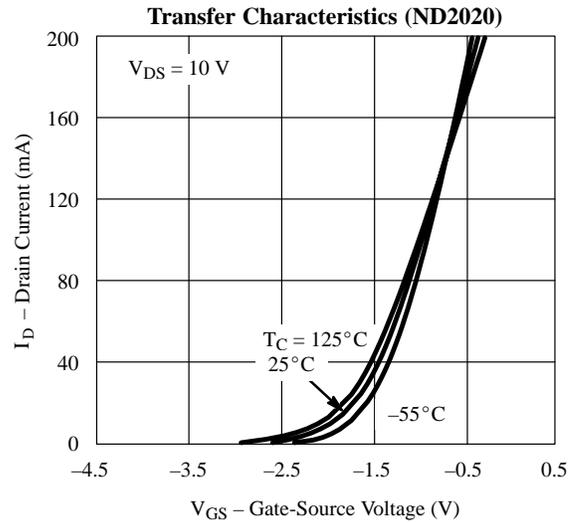
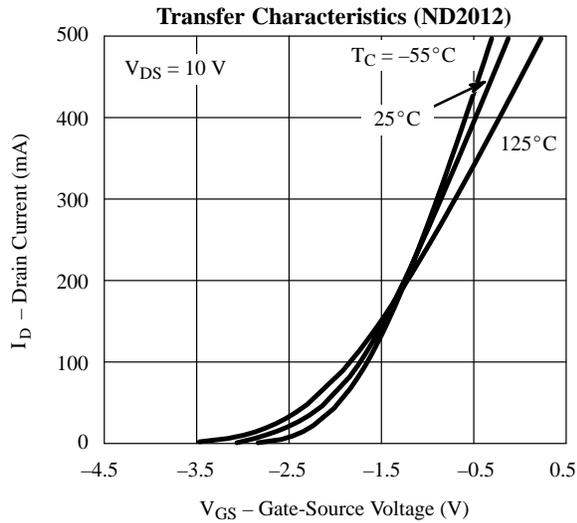
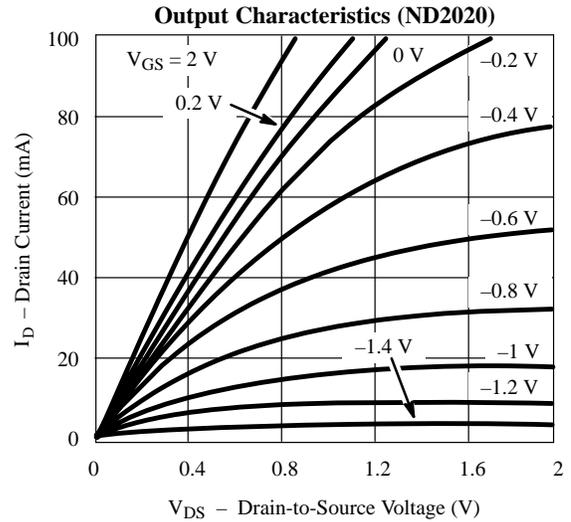
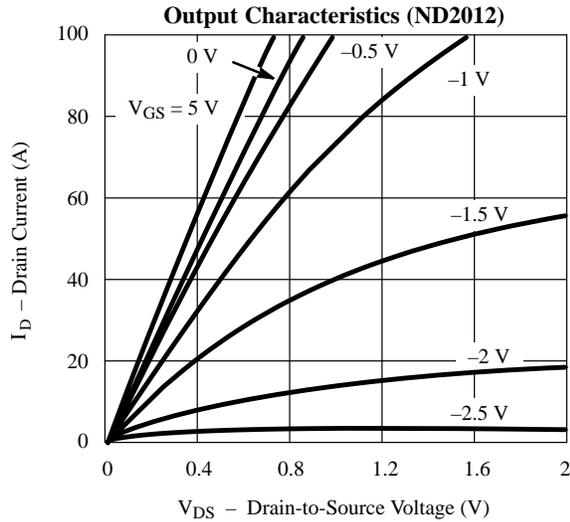
Parameter	Symbol	Test Conditions	Typ <sup>b</sup>	Limits				Unit
				ND2012L		ND2020L		
				Min	Max	Min	Max	
<b>Static</b>								
Drain-Source Breakdown Voltage	$V_{(BR)DSV}$	$V_{GS} = -8\text{ V}, I_D = 10\ \mu\text{A}$	220	200				V
		$V_{GS} = -5\text{ V}, I_D = 10\ \mu\text{A}$	220			200		
Gate-Source Cutoff Voltage	$V_{GS(off)}$	$V_{DS} = 5\text{ V}, I_D = 10\ \mu\text{A}$		-1.5	-4	-0.5	-2.5	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$ $T_J = 125^\circ\text{C}$			$\pm 10$		$\pm 10$	nA
					$\pm 50$		$\pm 50$	
Drain Cutoff Current	$I_{D(off)}$	$V_{DS} = 160\text{ V}, V_{GS} = -8\text{ V}$ $T_J = 125^\circ\text{C}$			1			$\mu\text{A}$
					200			
		$V_{DS} = 160\text{ V}, V_{GS} = -5\text{ V}$ $T_J = 125^\circ\text{C}$					1	
							200	
Drain-Saturation Current <sup>c</sup>	$I_{DSS}$	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}$	300	30		30		mA
Drain-Source On-Resistance <sup>c</sup>	$r_{DS(on)}$	$V_{GS} = 2\text{ V}, I_D = 20\text{ mA}$	7					$\Omega$
		$V_{GS} = 0\text{ V}, I_D = 20\text{ mA}$	8		12		20	
		$T_J = 125^\circ\text{C}$	12.6		30		50	
Forward Transconductance <sup>c</sup>	$g_{fs}$	$V_{DS} = 7.5\text{ V}, I_D = 20\text{ mA}$	55					mS
Common Source Output Conductance <sup>c</sup>	$g_{os}$		75					$\mu\text{S}$
<b>Dynamic</b>								
Input Capacitance	$C_{iss}$	$V_{DS} = 25\text{ V}, V_{GS} = -5\text{ V}, f = 1\text{ MHz}$	35		100		100	pF
Output Capacitance	$C_{oss}$		10		20		20	
Reverse Transfer Capacitance	$C_{rss}$		2		5		5	
<b>Switching<sup>d</sup></b>								
Turn-On Time	$t_{d(on)}$	$V_{DD} = 25\text{ V}, R_L = 1250\ \Omega$ $I_D \cong 20\text{ mA}, V_{GEN} = -5\text{ V}$ $R_G = 25\ \Omega$	20					ns
	$t_r$		20					
Turn-Off Time	$t_{d(off)}$		10					
	$t_f$		10					

Notes

- $T_A = 25^\circ\text{C}$  unless otherwise noted.
- For DESIGN AID ONLY, not subject to production testing.
- Pulse test:  $PW \leq 300\ \mu\text{s}$  duty cycle  $\leq 2\%$ .
- Switching time is essentially independent of operating temperature.

VDDQ20

## Typical Characteristics (25°C Unless Otherwise Noted)



## Typical Characteristics (25°C Unless Otherwise Noted) (Cont'd)

